

# RF Power Field Effect Transistor

## N-Channel Enhancement-Mode Lateral MOSFET

Designed for PCN and PCS base station applications at frequencies from 1900 to 2000 MHz. Suitable for TDMA, CDMA and multicarrier amplifier applications.

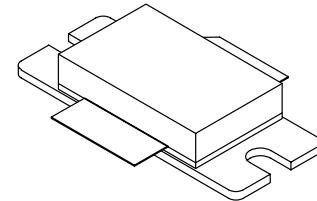
- Typical 2-Carrier N-CDMA Performance for  $V_{DD} = 28$  Volts,  $I_{DQ} = 1400$  mA, Avg.,  $P_{out} = 32$  Watts Avg.,  $f = 1990$  MHz, IS-95 CDMA (Pilot, Sync, Paging, Traffic Codes 8 Through 13) Channel Bandwidth = 1.2288 MHz. PAR = 9.8 dB @ 0.01% Probability on CCDF.
  - Power Gain — 14 dB
  - Drain Efficiency — 26%
  - IM3 @ 2.5 MHz Offset — -36.5 dBc in 1.2288 MHz Bandwidth
  - ACPR @ 885 kHz Offset — -50 dB in 30 kHz Bandwidth
- Capable of Handling 5:1 VSWR, @ 28 Vdc, 1960 MHz, 100 Watts CW Output Power

### Features

- Characterized with Series Equivalent Large-Signal Impedance Parameters
- Internally Matched for Ease of Use
- Qualified Up to a Maximum of 32 V Operation
- Integrated ESD Protection
- Lower Thermal Resistance Package
- Low Gold Plating Thickness on Leads, 40 $\mu$ " Nominal.
- RoHS Compliant
- In Tape and Reel. R3 Suffix = 250 Units per 56 mm, 13 inch Reel.

## MRF5S19150HR3

**1930-1990 MHz, 32 W AVG., 28 V  
2 x N-CDMA  
LATERAL N-CHANNEL  
RF POWER MOSFET**



CASE 465B-03, STYLE 1  
NI-880

**Table 1. Maximum Ratings**

Rating	Symbol	Value	Unit
Drain-Source Voltage	$V_{DSS}$	-0.5, +65	Vdc
Gate-Source Voltage	$V_{GS}$	-0.5, +15	Vdc
Total Device Dissipation @ $T_C = 25^\circ\text{C}$ Derate above $25^\circ\text{C}$	$P_D$	427 2.44	W W/ $^\circ\text{C}$
Storage Temperature Range	$T_{stg}$	-65 to +150	$^\circ\text{C}$
Case Operating Temperature	$T_C$	150	$^\circ\text{C}$
Operating Junction Temperature	$T_J$	200	$^\circ\text{C}$
CW Operation @ $T_C = 25^\circ\text{C}$ Derate above $25^\circ\text{C}$	CW	120 0.76	W W/ $^\circ\text{C}$

**Table 2. Thermal Characteristics**

Characteristic	Symbol	Value (1,2)	Unit
Thermal Resistance, Junction to Case Case Temperature 80 $^\circ\text{C}$ , 100 W CW Case Temperature 75 $^\circ\text{C}$ , 32 W CW	$R_{\theta JC}$	0.41 0.44	$^\circ\text{C}/\text{W}$

- MTTF calculator available at <http://www.freescale.com/rf>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.
- Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes - AN1955.

**Table 3. ESD Protection Characteristics**

Test Conditions	Class
Human Body Model	1 (Minimum)
Machine Model	M3 (Minimum)
Charge Device Model	C7 (Minimum)

**Table 4. Electrical Characteristics** ( $T_C = 25^\circ\text{C}$  unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
<b>Off Characteristics</b>					
Zero Gate Voltage Drain Leakage Current ( $V_{DS} = 65 \text{ Vdc}$ , $V_{GS} = 0 \text{ Vdc}$ )	$I_{DSS}$	—	—	10	$\mu\text{A dc}$
Zero Gate Voltage Drain Leakage Current ( $V_{DS} = 28 \text{ Vdc}$ , $V_{GS} = 0 \text{ Vdc}$ )	$I_{DSS}$	—	—	1	$\mu\text{A dc}$
Gate-Source Leakage Current ( $V_{GS} = 5 \text{ Vdc}$ , $V_{DS} = 0 \text{ Vdc}$ )	$I_{GSS}$	—	—	1	$\mu\text{A dc}$
<b>On Characteristics</b>					
Gate Threshold Voltage ( $V_{DS} = 10 \text{ Vdc}$ , $I_D = 360 \mu\text{A dc}$ )	$V_{GS(\text{th})}$	2.5	2.8	3.5	Vdc
Gate Quiescent Voltage ( $V_{DS} = 28 \text{ Vdc}$ , $I_D = 1400 \text{ mA dc}$ )	$V_{GS(Q)}$	—	3.8	—	Vdc
Drain-Source On-Voltage ( $V_{GS} = 10 \text{ Vdc}$ , $I_D = 3.6 \text{ Adc}$ )	$V_{DS(\text{on})}$	—	0.24	—	Vdc
Forward Transconductance ( $V_{DS} = 10 \text{ Vdc}$ , $I_D = 3.6 \text{ Adc}$ )	$g_{fs}$	—	9	—	S
<b>Dynamic Characteristics</b>					
Reverse Transfer Capacitance (1) ( $V_{DS} = 28 \text{ Vdc}$ , $V_{GS} = 0$ , $f = 1 \text{ MHz}$ )	$C_{rss}$	—	3.1	—	pF

**Functional Tests** (In Freescale Test Fixture, 50 ohm system)  $V_{DD} = 28 \text{ Vdc}$ ,  $I_{DQ} = 1400 \text{ mA}$ ,  $P_{out} = 32 \text{ W Avg.}$ ,  $f_1 = 1987.5 \text{ MHz}$ ,  $f_2 = 1990 \text{ MHz}$ , 2-Carrier N-CDMA, 1.2288 MHz Channel Bandwidth Carriers. ACPR measured in 30 kHz Channel Bandwidth @  $\pm 885 \text{ kHz}$  Offset. IM3 measured in 1.2288 MHz Channel Bandwidth @  $\pm 2.5 \text{ MHz}$  Offset. PAR = 9.8 dB @ 0.01% Probability on CCDF.

Power Gain	Gps	13	14	—	dB
Drain Efficiency	$\eta_D$	24	26	—	%
Intermodulation Distortion	IM3	—	-36.5	-35	dBc
Adjacent Channel Power Ratio	ACPR	—	-50	-48	dBc
Input Return Loss	IRL	—	-17	-9	dB

- Part internally matched both on input and output.

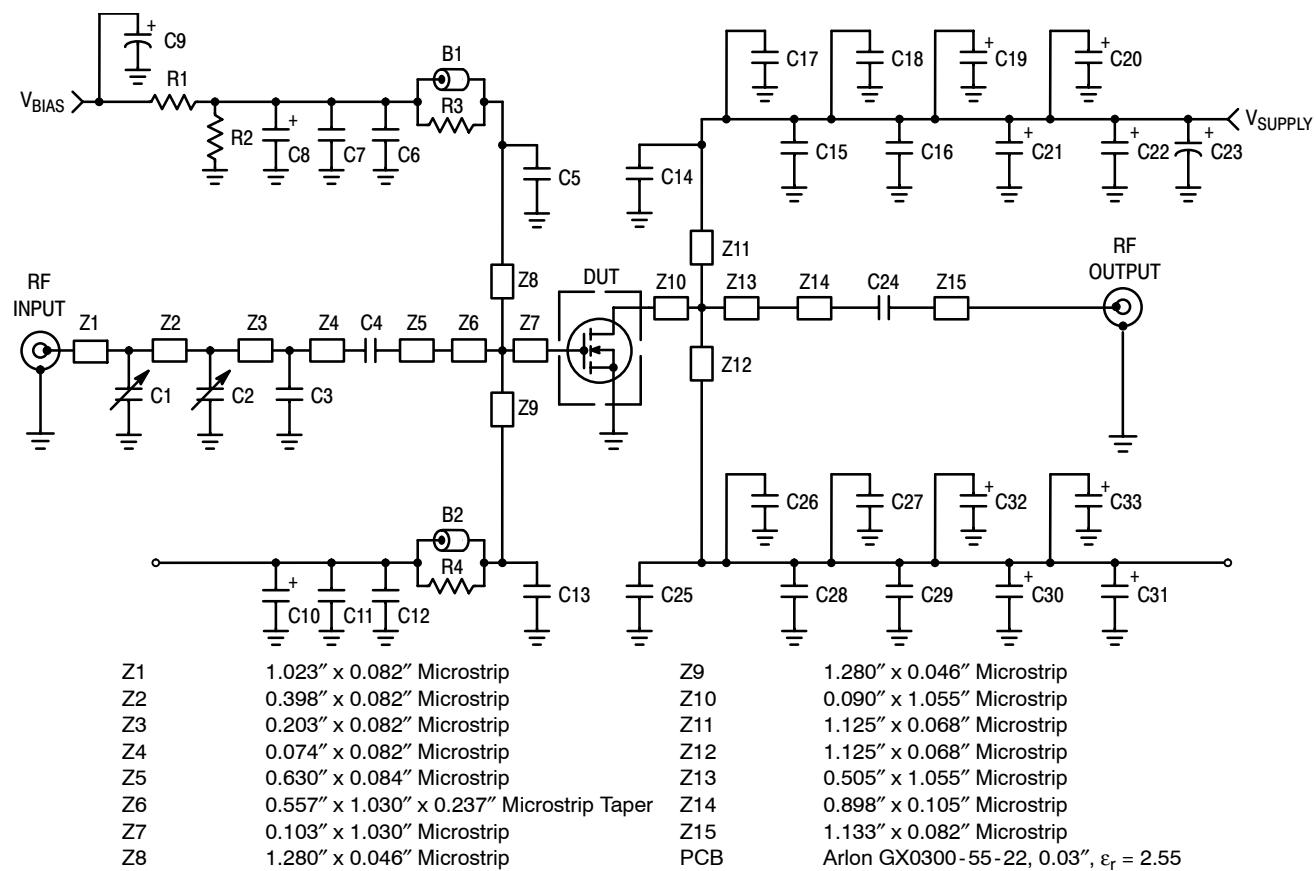
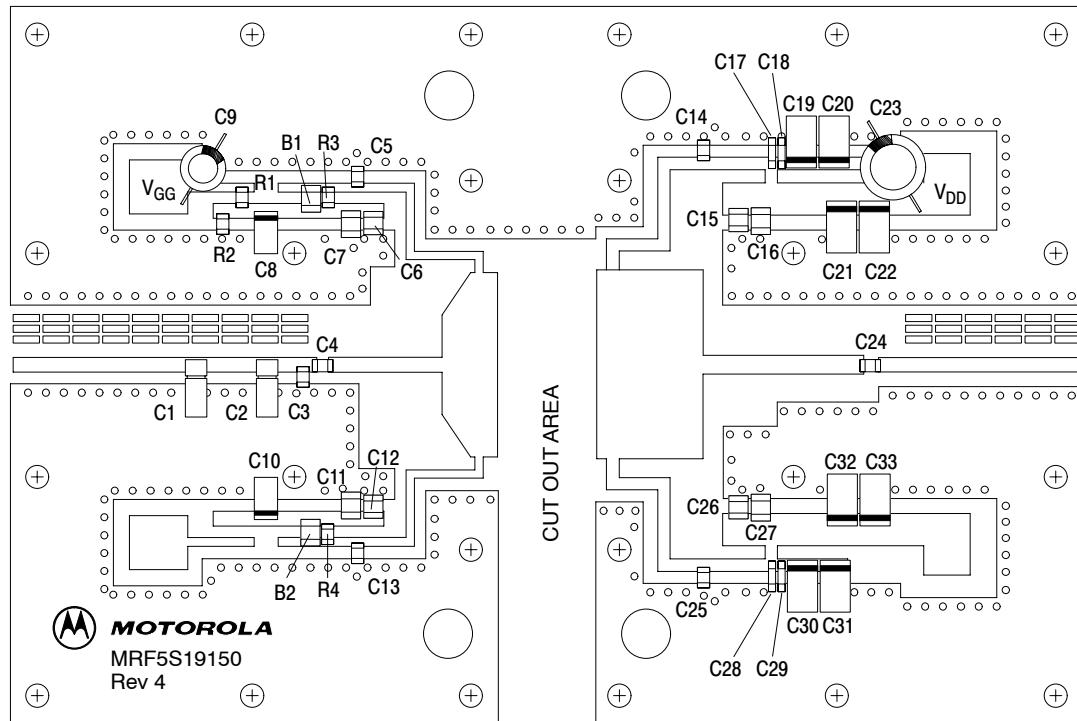


Figure 1. MRF5S19150HR3 Test Circuit Schematic

Table 5. MRF5S19150HR3 Test Circuit Component Designations and Values

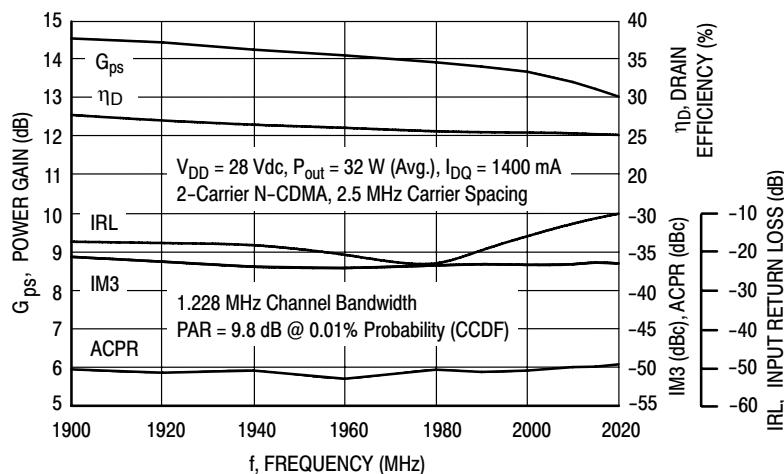
Part	Description
B1, B2	Short RF Beads, Fair-Rite #2743019447
C1, C2	0.6 – 4.5 Variable Capacitors, Gigatrim, Johanson #27271SL
C3	0.8 pF Chip Capacitor, ATC #ATC100B0R8JT500XT
C4, C5, C13, C14, C24, C25	9.1 pF Chip Capacitors, ATC #ATC100B9R1JT500XT
C8, C10	1.0 $\mu$ F, 50 V SMT Tantalum Capacitors, Kemet #T491C105M050AT
C6, C12, C16, C17, C18, C27, C28, C29	0.1 $\mu$ F Chip Capacitors, Kemet #CDR33BX104AKYS
C7, C11, C15, C26	1000 pF Chip Capacitors, ATC #ATC100B102JT50XT
C9	100 $\mu$ F, 50 V Electrolytic Capacitor, Multicomp #MCHT101M1HB-1017-RH
C23	470 $\mu$ F, 63 V Electrolytic Capacitor, Multicomp #EKME630ELL471MK25S
C19, C20, C21, C22, C30, C31, C32, C33	22 $\mu$ F, 35 V Tantalum Capacitors, Kemet #T491D226M035AS
R1	1 k $\Omega$ , 1/4 W Chip Resistor, Vishay #CRCW12061001FKEA
R2	560 k $\Omega$ , 1/4 W Chip Resistor, Vishay #CRCW12065600FKEA
R3, R4	12 $\Omega$ , 1/4 W Chip Resistors, Vishay #CRCW120612R0FKEA



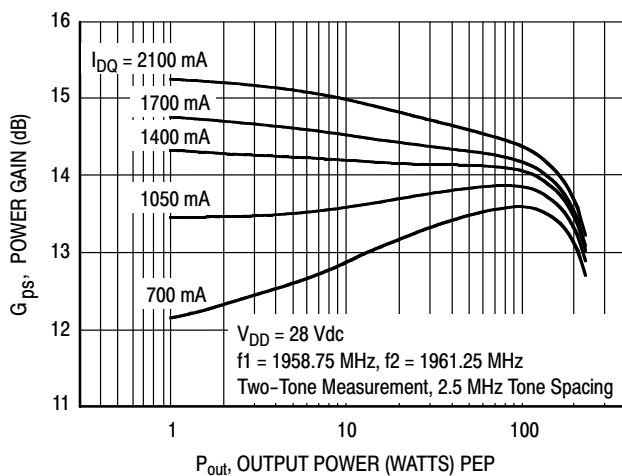
Freescale has begun the transition of marking Printed Circuit Boards (PCBs) with the Freescale Semiconductor signature/logo. PCBs may have either Motorola or Freescale markings during the transition period. These changes will have no impact on form, fit or function of the current product.

**Figure 2. MRF5S19150HR3 Test Circuit Component Layout**

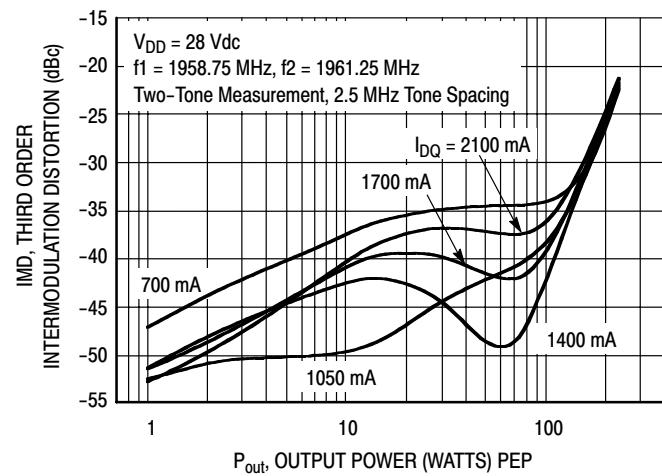
## TYPICAL CHARACTERISTICS



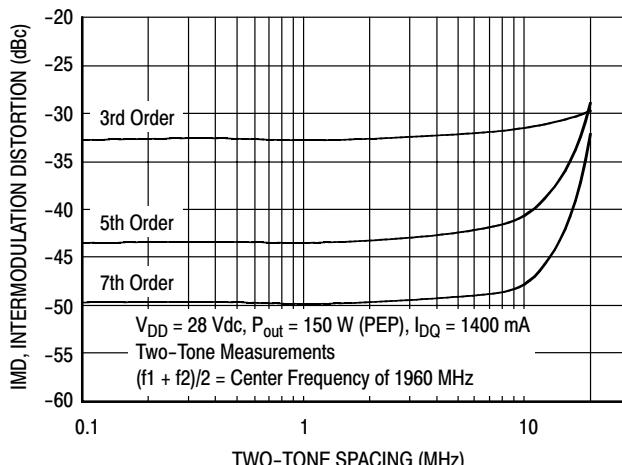
**Figure 3. 2-Carrier N-CDMA Broadband Performance  
@  $P_{out} = 32$  Watts Avg.**



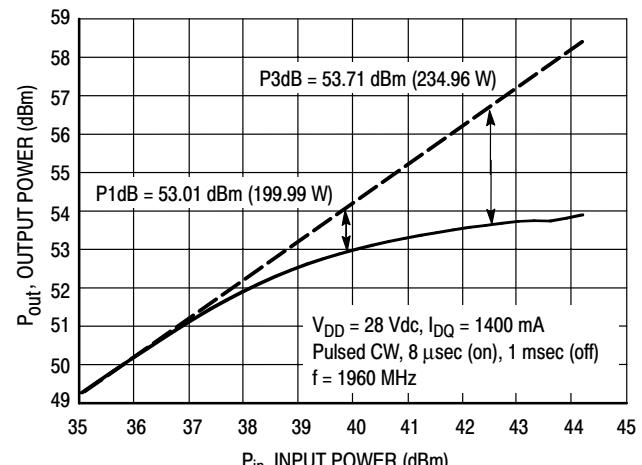
**Figure 4. Two-Tone Power Gain versus Output Power**



**Figure 5. Third Order Intermodulation versus Output Power**

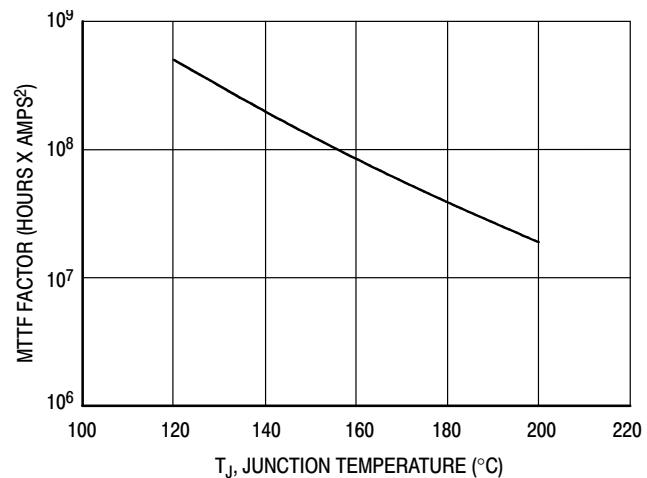
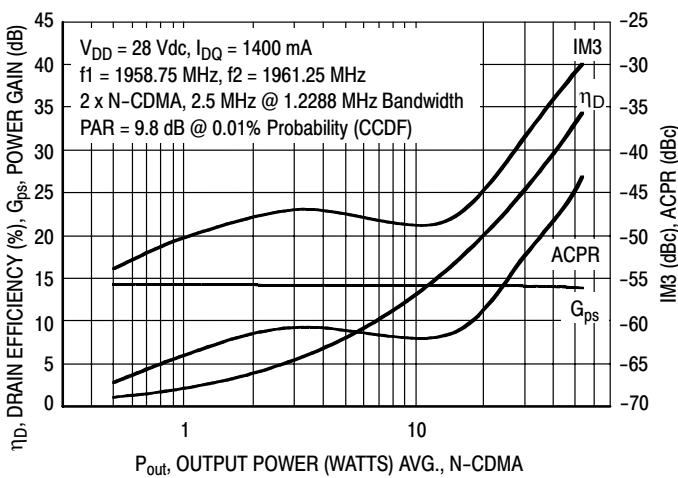


**Figure 6. Intermodulation Distortion Products versus Tone Spacing**

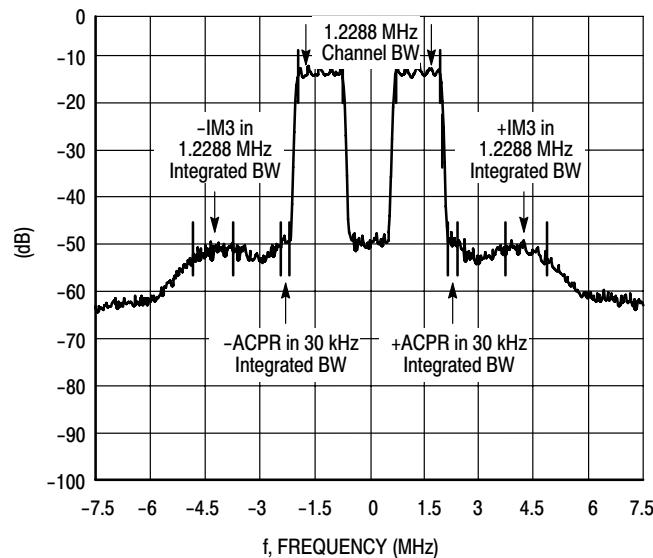


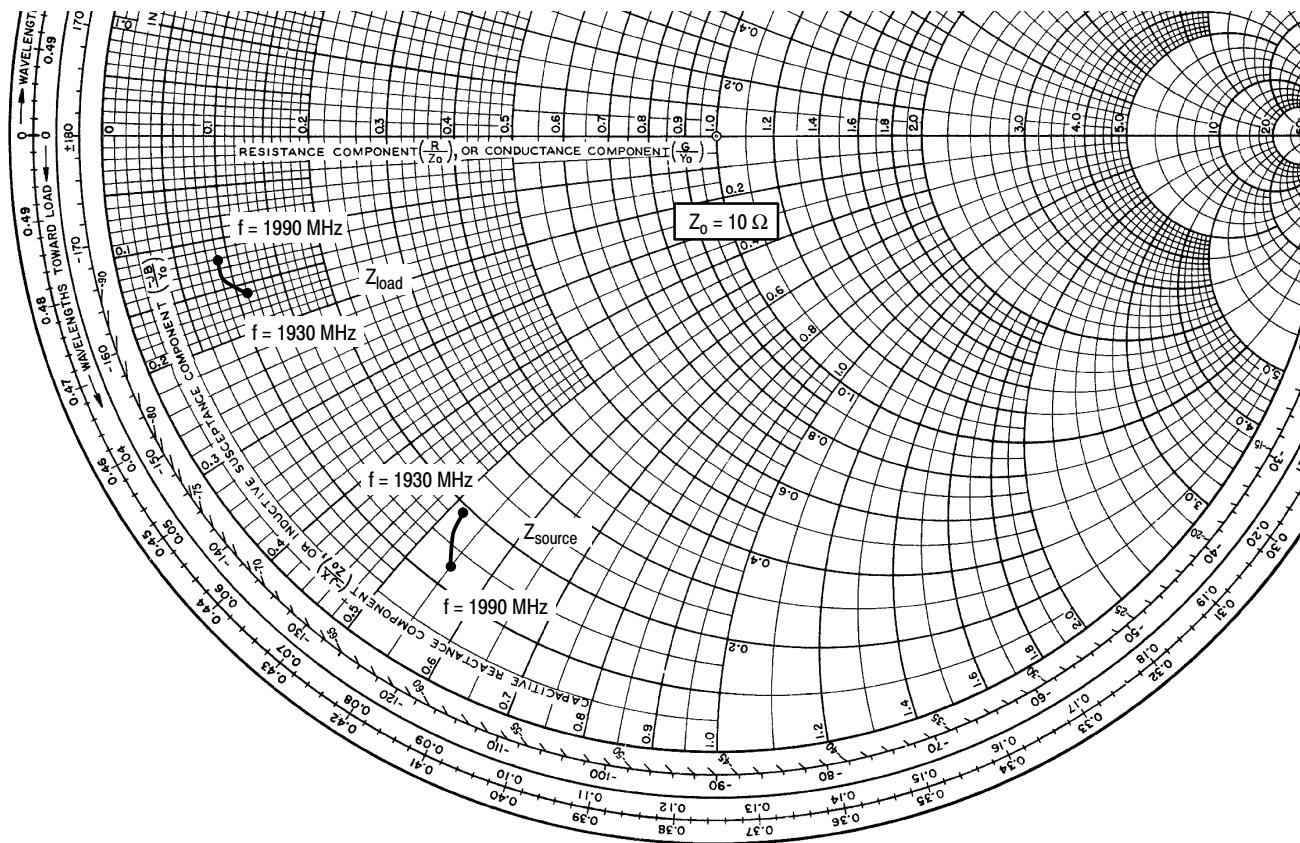
**Figure 7. Pulse CW Output Power versus Input Power**

## TYPICAL CHARACTERISTICS



### N-CDMA TEST SIGNAL





$$V_{DD} = 28 \text{ V}, I_{DQ} = 1400 \text{ mA}, P_{\text{out}} = 32 \text{ W Avg.}$$

$f$ MHz	$Z_{\text{source}}$ $\Omega$	$Z_{\text{load}}$ $\Omega$
1930	$1.89 - j5.24$	$1.06 - j1.58$
1960	$1.64 - j5.29$	$0.88 - j1.37$
1990	$1.3 - j5.49$	$0.90 - j1.21$

$Z_{\text{source}}$  = Test circuit impedance as measured from gate to ground.

$Z_{\text{load}}$  = Test circuit impedance as measured from drain to ground.

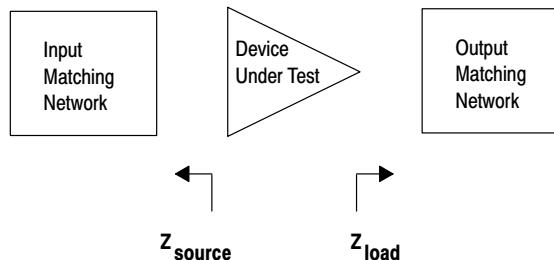
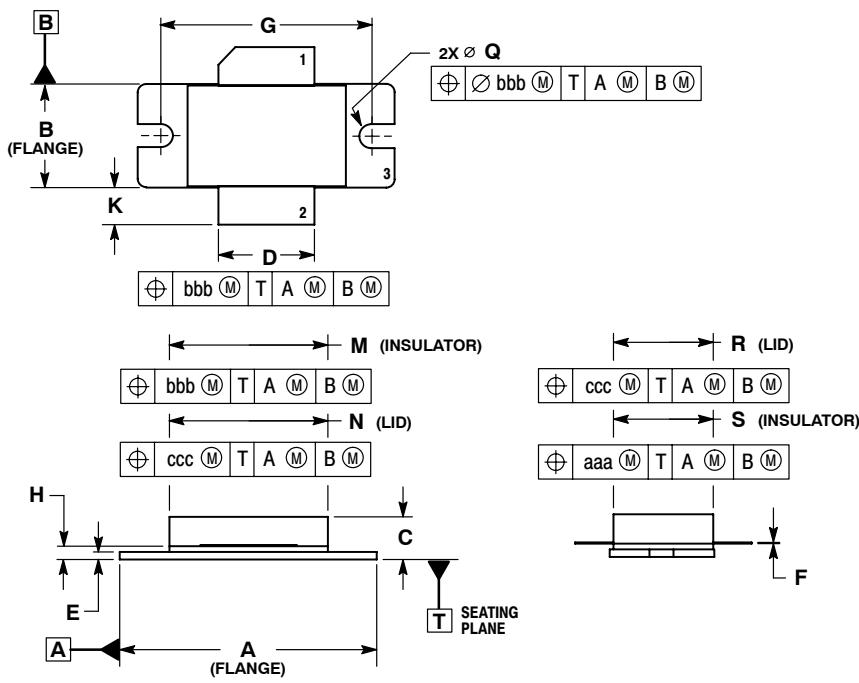


Figure 11. Series Equivalent Source and Load Impedance

## PACKAGE DIMENSIONS



NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M-1994.
- CONTROLLING DIMENSION: INCH.
- DIMENSION H IS MEASURED 0.030 (0.762) AWAY FROM PACKAGE BODY.
- DELETED

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	1.335	1.345	33.91	34.16
B	0.535	0.545	13.6	13.8
C	0.147	0.200	3.73	5.08
D	0.495	0.505	12.57	12.83
E	0.035	0.045	0.89	1.14
F	0.003	0.006	0.08	0.15
G	1.100 BSC		27.94 BSC	
H	0.057	0.067	1.45	1.70
K	0.170	0.210	4.32	5.33
M	0.872	0.888	22.15	22.55
N	0.871	0.889	19.30	22.60
Q	Ø .118	Ø .138	Ø 3.00	Ø 3.51
R	0.515	0.525	13.10	13.30
S	0.515	0.525	13.10	13.30
aaa	0.007 REF		0.178 REF	
bbb	0.010 REF		0.254 REF	
ccc	0.015 REF		0.381 REF	

STYLE 1:  
PIN 1. DRAIN  
2. GATE  
3. SOURCE

**CASE 465B-03  
ISSUE D  
NI-880  
MRF5S19150HR3**

## PRODUCT DOCUMENTATION

Refer to the following documents to aid your design process.

### Application Notes

- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

### Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

## REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
4	Nov. 2008	<ul style="list-style-type: none"><li>• Data sheet revised to reflect part status change, p. 1</li><li>• Modified data sheet to reflect RF Test Reduction described in Product and Process Change Notification number, PCN12779, p. 1, 2</li><li>• Updated Part Numbers in Table 5, Component Designations and Values, to latest RoHS compliant part numbers, p. 3</li><li>• Added Product Documentation and Revision History, p. 9</li></ul>

MRF5S19150HR3

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